Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/771,760	DAUGHERTY ET AL.
Examiner	Art Unit
Chau N. Nguyen	2831

<u></u>					
SEARCHED					
Class	Subclass	Date	Examiner		
174	75C	2/23/05	cv		
	78				
	74R		<u> </u>		
update	all	1/26/05	CN		
	•				
			:		
	. 10				
-					

ואו	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
See	Print	11/26/05	en		
	out				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
•				
· · · · · · · · · · · · · · · · · · ·				
,				
•				